

Notice of References Cited

Application/Control No.

09/507,542

Applicant(s)/Patent Under
Reexamination
DAVIDSON ET AL.

Examiner

Eduardo Garcia-Otero

Art Unit

2123

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U.S. PATENT DOCUMENTS

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	P					
	Q					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	H.S.M. Coxeter, Introduction to Geometry Second Edition, John Wiley & Sons, Inc., 1989, Second Edition, pages 216 to 221.
*	V	D.M.Y. Sommerville, Analytical Gometry of three Dimensions, Cambridge University Press, 1959, pages 26-31 and 336-341.
*	W	J. Plucker, On a New Geometry of Spaces, pages 725-727.
*	X	K.H. Hunt, Kinematic Geometry of Mechanisms, Clarendon Press, Oxford, 1978, pages 304-307.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	ACIS Geometric Modeler Application Guide, Spatial Technology, Inc., 1996, page 1-1 to page 4-10.
*	V	Francesco Chiesi et al., Tolerance Analysis with eM-TolMate, Transactions of the ASME, Vol 3 March 2003, page 100-105.
*	W	Zengshu Shen, Tolerance Analysis with EDS/VisVSA, Journal of Computing and Information Science in Engineering, March 2003 Volume 3, pages 95-99.
*	X	The 3D DCM Manual Version 2.6.0, D-Cubed Ltd., March 2002, pages 1-29.

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	Q					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	T. Kandikhan et al., A mechanism for validating dimensioning and tolerancing schemes in CAD systems, Computer-Aided Design 33 (2001), pages 721-737.
*	V	Jami J. Shah et al., Representation and mapping of geometric dimensions from design to manufacture, Proceedings of the 1996 ASME Design Engineering Technical Conferences and Computers in Engineering Conference, 1996. 96-DETC-DAC-1481.
	W	
	X	

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